



Dynamic characterisation of analogue-to-digital converters /

Dallet, Dominique (1964-)
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Monografía

The Analogue-to-digital converter (ADC) is the most pervasive block in electronic systems. This book presents an overview of the methods and procedures employed for characterising ADCs dynamic performance behaviour using sinusoidal stimuli. It describes the three classical methods - histogram, sine wave fitting, and spectral analysis

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